

N-Channel Enhancement Mode Power MOSFET

Dual Asymmetric N-Channel MOSFET

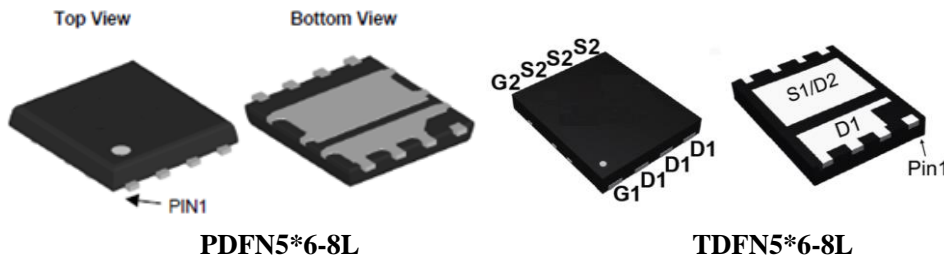
● Features

- $V_{DS} = 30V$,
- $I_D = 48.7A$
- $R_{DS(ON)} @ V_{GS} = 10V$ TYP 3.8mΩ
- $R_{DS(ON)} @ V_{GS} = 4.5V$ TYP 6.0mΩ

● General Description

- CPU core power
- POL
- Computer / server peripherals
- Synchronous buck converter
- Telecom DC/DC

● Pin Configurations



● Absolute Maximum Ratings @ $T_C=25^\circ C$ unless otherwise noted

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DSS}	30	V
Gate-Source Voltage	V_{GSS}	± 20	V
Drain Current (Continuous) *C	I_D	$T_C=25^\circ C$	48.7
		$T_C=70^\circ C$	39
Drain Current (Pulse) *B	I_{DM}	195	A
Power Dissipation	P_D	20.2	W
Operating Temperature/ Storage Temperature	T_J/T_{STG}	-55~150	$^\circ C$

● Thermal Resistance Ratings

Parameter	Symbol	Maximum	Unit
Maximum Junction-to-Ambient *A	R_{thJA}	20	$^\circ C/W$
Maximum Junction-to-Case (Drain)	R_{thJC}	6.2	

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● **Electrical Characteristics** @ $T_A=25^{\circ}\text{C}$ unless otherwise noted

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static *D						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	30	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 24V, V_{GS} = 0V$	--	--	1	μA
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_{DS} = 250\mu A$	1	--	2.5	V
Gate Leakage Current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$	--	--	± 100	nA
Drain-Source On-state Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 10A$	--	3.8	5.0	m Ω
	$R_{DS(on)}$	$V_{GS} = 4.5V, I_D = 7A$	--	6.0	7.8	m Ω
Diode Forward Voltage	V_{SD}	$I_{SD} = 1A, V_{GS} = 0V$	--	--	1.2	V
Diode Forward Current *C	I_S	$T_C = 25^{\circ}\text{C}$	--	--	16.8	A
Switching						
Total Gate Charge	Q_g	$V_{DS} = 15V, I_D = 10A,$ $V_{GS} = 5V$	--	13.8	--	nC
Gate-Source Charge	Q_{gs}		--	2.5	--	nC
Gate-Drain Charge	Q_{gd}		--	8	--	nC
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = 15V, I_D = 1A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$	--	14.5	--	ns
Turn-on Rise Time	t_r		--	7.5	--	ns
Turn-off Delay Time	$t_{d(off)}$		--	37	--	ns
Turn-Off Fall Time	t_f		--	12	--	ns
Dynamic						
Input Capacitance	C_{iss}	$V_{DS} = 15V, V_{GS} = 0V, f = 1.0\text{MHz}$	--	760	--	pF
Output Capacitance	C_{oss}		--	186	--	pF
Reverse Transfer Capacitance	C_{rss}		--	116	--	pF

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}\text{C}$. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C: The current rating is based on the $t \leq 10\text{s}$ junction to ambient thermal resistance rating.

D: Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.

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● Typical Performance Characteristics (T_J = 25 °C, unless otherwise noted)

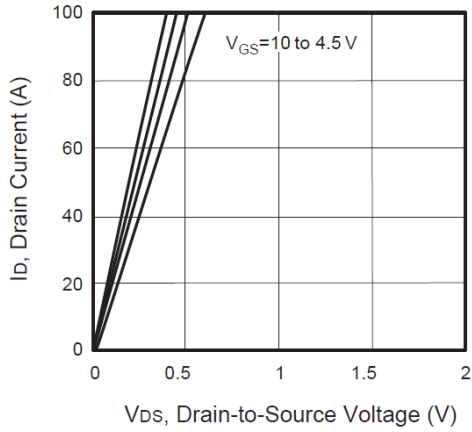


Figure 1. Output Characteristics

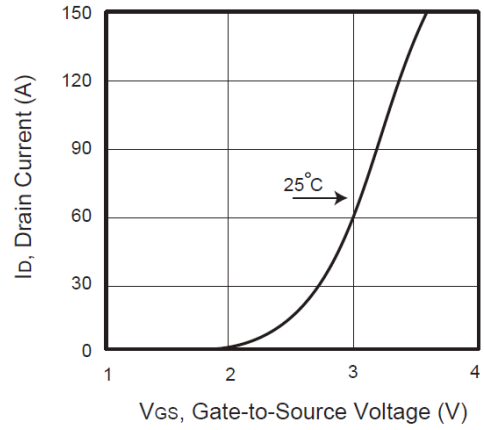


Figure 2. Transfer Characteristics

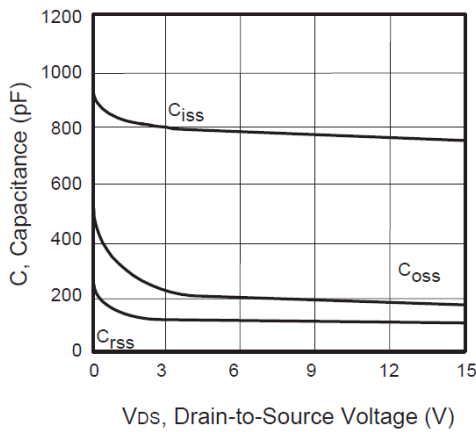


Figure 3. Capacitance

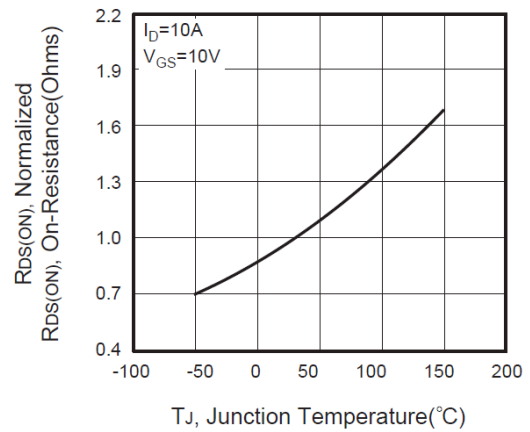


Figure 4. On-Resistance Variation with Temperature

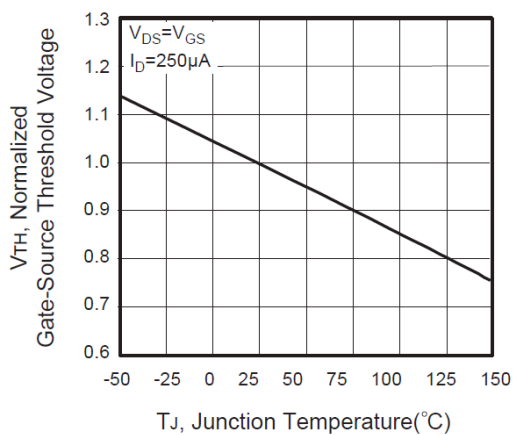


Figure 5. Gate Threshold Variation with Temperature

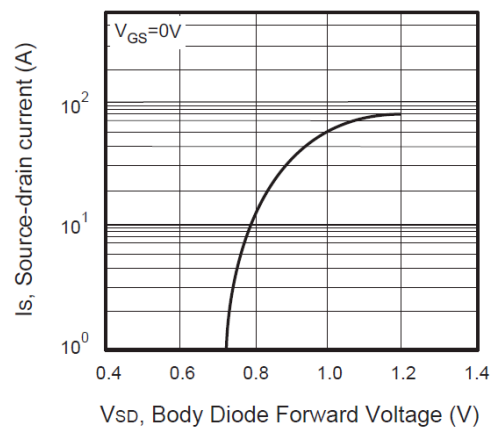


Figure 6. Body Diode Forward Voltage Variation with Source Current

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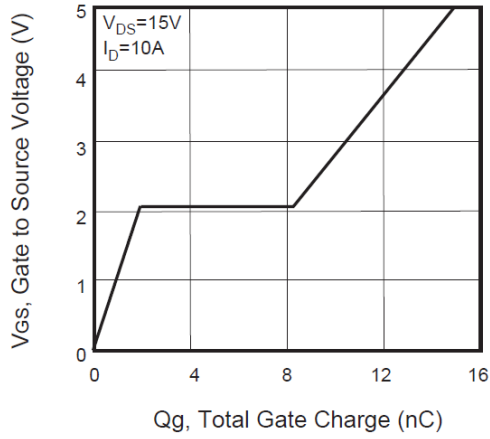


Figure 7. Gate Charge

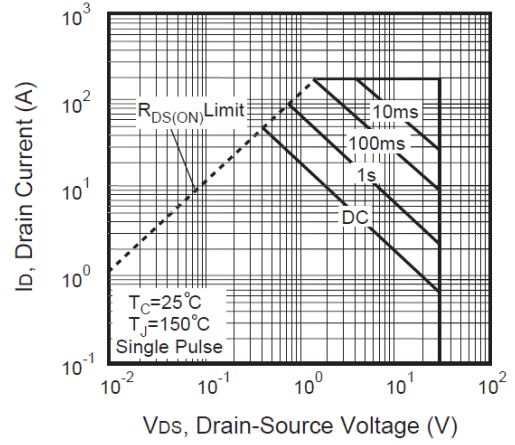


Figure 8. Maximum Safe Operating Area

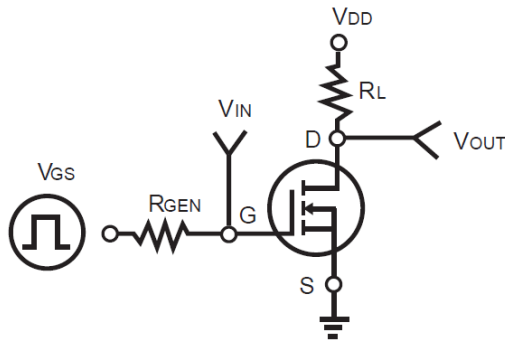


Figure 9. Switching Test Circuit

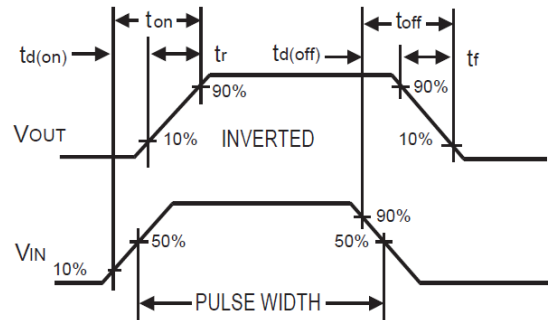


Figure 10. Switching Waveforms

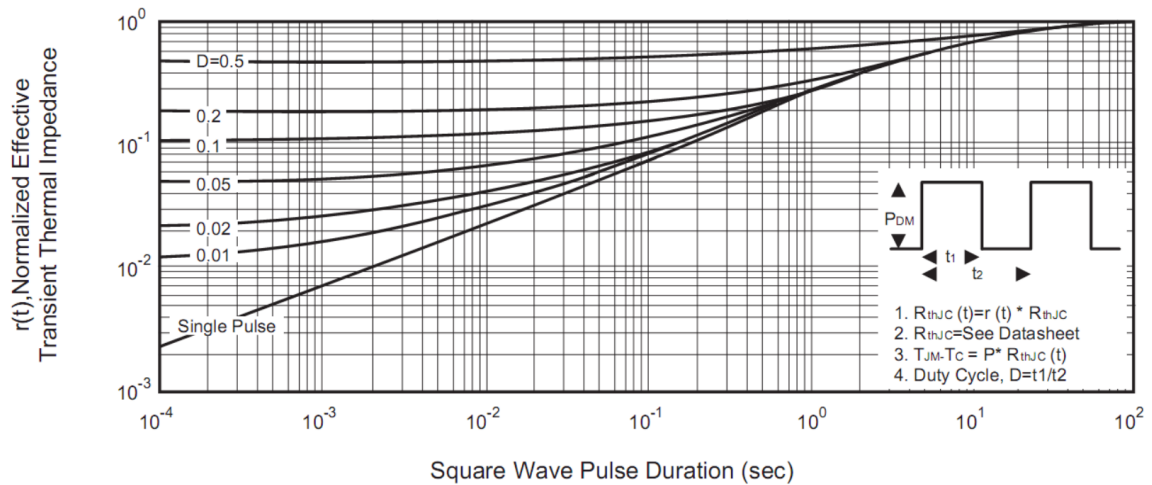
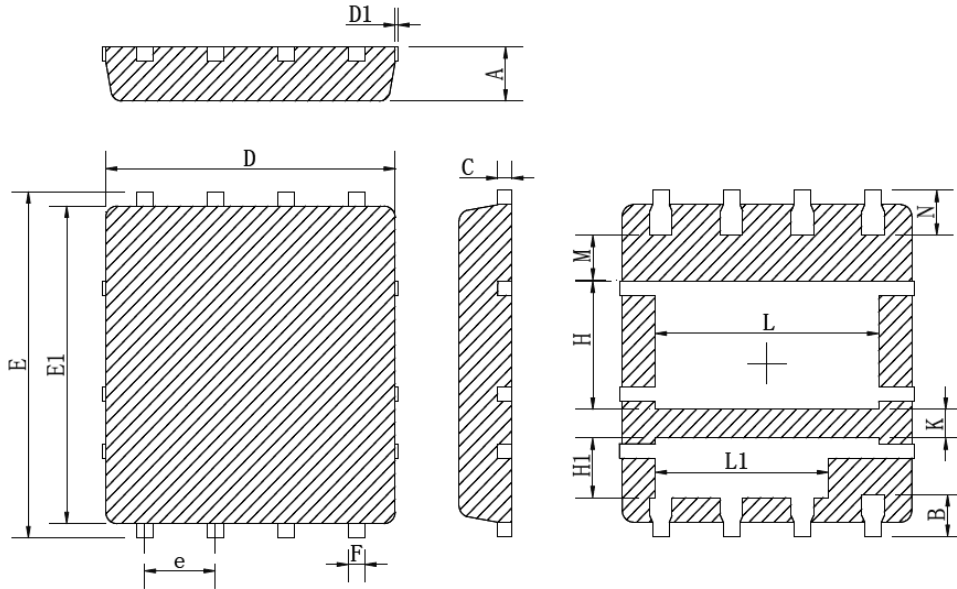


Figure 11. Normalized Thermal Transient Impedance Curve

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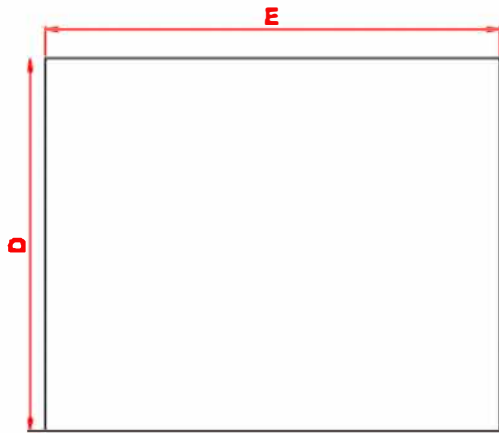
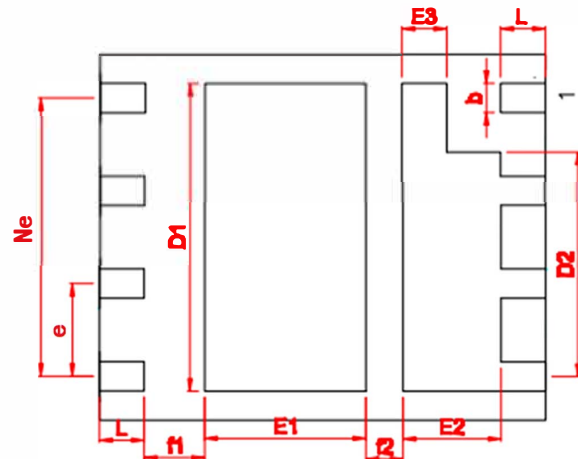
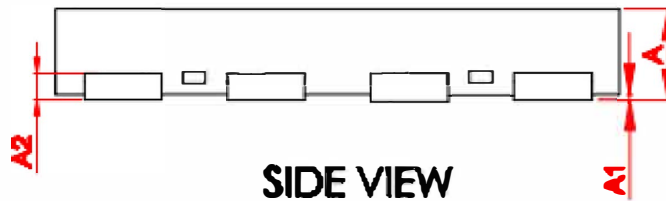
- Package Information

LTS6694FTB OUTLINE



Symbol	Min	Typ	Max
A	0.90	0.95	1.00
B	0.60	0.70	0.80
C	0.20	0.254	0.30
D	5.10	5.20	5.30
D1			0.12
E	5.95	6.05	6.15
E1	5.40	5.55	5.70
e	1.22	1.27	1.32
F	0.25	0.30	0.35
H	2.12	2.22	2.32
H1	0.94	1.04	0.14
L	3.80	4.00	4.20
M	0.70	0.80	0.90
N	0.65	0.75	0.85
K	0.40	0.50	0.60

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TOP VIEW

BOTTOM VIEW

SIDE VIEW

SYMBOL	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.700	0.750	0.800
A1	0.000	0.020	0.050
b	0.360	0.410	0.480
A2	0.190	0.210	0.250
D	4.900	5.000	5.100
D1	4.150	4.200	4.250
D2	2.870	3.070	3.270
E	5.900	6.000	6.100
E1	2.020	2.170	2.320
E2	1.220	1.320	1.420
E3	0.550	0.600	0.650
e	1.220	1.270	1.320
Ne	BSC 3.810		
f1	0.710	0.810	0.910
f2	0.400	0.500	0.600
L	0.550	0.600	0.650

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Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb device	245°C ±5°C	5sec±1sec
Pb-Free device	260°C +0/-5°C	5sec±1sec



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